

Notice of References Cited	Application/Control No. 10/616,097		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Edna Wong		Art Unit 1753	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0155247	08-2003	Miura et al.	205/157
	B	US-2004/0072419	04-2004	Baskaran et al.	438/627
*	C	US-6,432,821	08-2002	Dubin et al.	438/678
*	D	US-6,709,563	03-2004	Nagai et al.	205/123
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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